


Search Notes 	Application/Control No. 10052411	Applicant(s)/Patent Under Reexamination LEE, JONG HAN
	Examiner Emmanuel Bayard	Art Unit 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	229, 232, 233, 234	4/3/2008	EB

SEARCH NOTES		
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East	4/3/2008	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	229, 233	4/3/2008	EB